

<b>Notice of References Cited</b>		Application/Control No. 10/574,243	Applicant(s)/Patent Under Reexamination TAMURA ET AL.	
		Examiner MUHAMMAD N. EDUN	Art Unit 2627	Page 1 of 1

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*	C	US-7,224,888	05-2007	Kikuchi et al.	386/95
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	K	US-			
	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

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